

Search Notes

Application No.

09/674,090

Applicant(s)

EICHEN ET AL.

Examiner

Young J. Kim

Art Unit

1637

SEARCHED

| Class | Subclass | Date | Examiner |
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| 435 | 6 | | |
| 536 | 24.3 | | |
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INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|---|------------|------|
| Patent Database (USPT, USPGP, EPO, JPO, DERWENT, IBM-TDB) | 11/29/2004 | YJK |
| Consulted Primary Officer, BJ Forman | 11/29/2004 | YJK |
| See enclosed for search strategies | 11/29/2004 | YJK |
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